

<b>Notice of References Cited</b>	Application/Control No. 10/523,347		Applicant(s)/Patent Under Reexamination SHIMIZU ET AL.	
	Examiner JASON RECEK		Art Unit 2442	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0018772 A1	08-2001	Shibata et al.	725/93
*	B	US-2003/0204613 A1	10-2003	Hudson et al.	709/231
*	C	US-2003/0204585 A1	10-2003	Yao et al.	709/224
*	D	US-6,778,537 B1	08-2004	Ishibashi, Yasuhiro	370/395.62
*	E	US-2005/0120131 A1	06-2005	Allen, Arthur Douglas	709/233
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.